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Diode

Silicon Carbide Schottky Diode

IDH20G120C5

5th Generation thinQ!™ 1200 V SiC Schottky Diode

IDH20G120C5

Rev. 2.0 2015-09-03

Industrial Power Control



thinQ!TM SiC Schottky Diode

Features:

- Revolutionary semiconductor material Silicon Carbide
- No reverse recovery current / No forward recovery
- Temperature independent switching behavior
- Low forward voltage even at high operating temperature
- Tight forward voltage distribution
- Excellent thermal performance
- Extended surge current capability
- Specified dv/dt ruggedness
- Qualified according to JEDEC¹⁾ for target applications
- Pb-free lead plating; RoHS compliant

Benefits

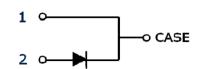
- System efficiency improvement over Si diodes
- Enabling higher frequency / increased power density solutions
- System size / cost savings due to reduced heatsink requirements and smaller magnetics
- Reduced EMI
- Highest efficiency across the entire load range
- Robust diode operation during surge events
- High reliability
- RelatedLinks: www.infineon.com/sic

Applications

- Solar inverters
- Uninterruptable power supplies
- Motor drives
- Power Factor Correction

Package pin definitions

- Pin 1 and backside cathode
- Pin 2 anode













Key Performance and Package Parameters

Туре	$V_{ m DC}$	I _F	Q c	$T_{j,max}$	Marking	Package
IDH20G120C5	1200V	20A	82nC	175°C	D2012C5	PG-TO220-2-1

1) J-STD20 and JESD22





5th Generation thinQ!™ 1200 V SiC Schottky Diode

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Maximum ratings

Parameter	Symbol	Symbol Value		
Repetitive peak reverse voltage	V_{RRM}	1200	V	
Continues forward current for $R_{th(j-c,max)}$ $T_C = 150$ °C, D=1 $T_C = 135$ °C, D=1 $T_C = 25$ °C, D=1	I _F	20 27 56	А	
Surge non-repetitive forward current, sine halfwave $T_{\rm C}$ =25°C, $t_{\rm p}$ =10ms $T_{\rm C}$ =150°C, $t_{\rm p}$ =10ms	I _{F,SM}	198 168	А	
Non-repetitive peak forward current $T_{\rm C} = 25^{\circ}{\rm C}$, $t_{\rm p}=10~\mu{\rm s}$	<i>I</i> _{F,max} 1200		А	
i²t value $T_{\rm C}$ = 25°C, $t_{\rm p}$ =10 ms $T_{\rm C}$ = 150°C, $t_{\rm p}$ =10 ms	∫ i²dt	195 140	A²s	
Diode dv/dt ruggedness V _B =0960V	d <i>v</i> /d <i>t</i>	80	V/ns	
Power dissipation $T_C = 25^{\circ}C$	P _{tot}	330	W	
Operating and storage temperature	T _j ;T _{stg}	-55175	°C	
Soldering temperature, wavesoldering only allowed at leads, 1.6mm (0.063 in.) from case for 10 s	T _{sold}	260	°C	
Mounting torque M3 and M4 screws	М	0.7	Nm	

Thermal Resistances

Parameter	Cumbal	Conditions			Value	
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Characteristic						
Diode thermal resistance, junction – case	R _{th(j-c)}		-	0.35	0.46	K/W
Thermal resistance, junction – ambient	R _{th(j-a)}	leaded	-	-	62	K/W



Electrical Characteristics

Static Characteristics, at T_j=25°C, unless otherwise specified

Parameter	Symbol	Conditions		Value		Unit
raiailletei		Conditions	min.	typ.	max.	Oilit
Static Characteristic						
DC blocking voltage	$V_{ m DC}$	T _j = 25°C	1200	-	-	V
Diada forward voltage	V _F	$I_{\rm F}$ = 20A, $T_{\rm j}$ =25°C	-	1.5	1.8	V
Diode forward voltage		$I_{\rm F}$ = 20A, $T_{\rm j}$ =150°C	-	2.0	2.6	
Poverse surrent	I _R	V _R =1200V, T _j =25°C		8.5	123	μА
Reverse current		$V_{\rm R}$ =1200V, $T_{\rm j}$ =150°C		44	630	

Dynamic Characteristics, at T_j =25°C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
- rai ailletei	Syllibol		min.	typ.	max.	Oilit
Dynamic Characteristics	Dynamic Characteristics					_
Total capacitive charge		V _R =800V, T _j =150°C				
	$Q_{\mathbb{C}}$	$Q_C = \int_C^{V_R} C(V) dV$	-	82	-	nC
		0				
		V _R =1 V, <i>f</i> =1 MHz	-	1050	-	
Total Capacitance	C	V _R =400 V, <i>f</i> =1 MHz	-	74	-	pF
		V _R =800 V, f=1 MHz	-	59	-	



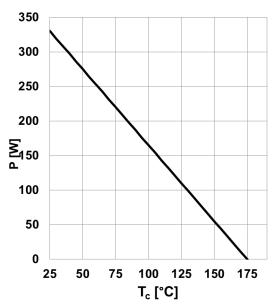


Figure 1. Power dissipation as a function of case temperature, $P_{\rm tot} = f(T_{\rm C}, P_{\rm th(j-c),max})$

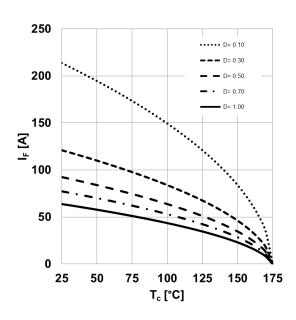


Figure 2. Diode forward current as function of temperature, $T_j \le 175$ °C, $R_{\text{th(j-c)},\text{max}}$, parameter D=duty cycle, V_{th} , R_{diff} @ T_{j} =175°C

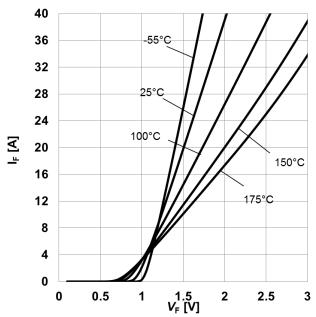


Figure 3. **Typical forward characteristics,** $I_F = f(V_F)$, $t_D = 10 \mu s$, parameter: T_i

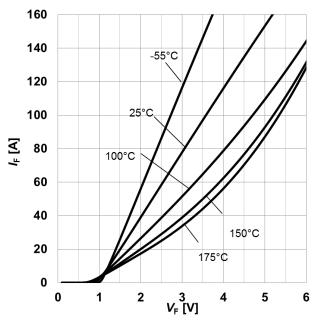


Figure 4. Typical forward characteristics in surge current, $I_F=f(V_F)$, $t_p=10 \mu s$, parameter: T_i



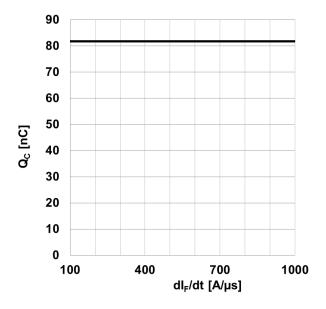


Figure 5. **Typical capacitive charge as function** of current slope¹, $Q_{\mathbb{C}}=f(dI_{\mathbb{F}}/dt)$, $T_{j}=150^{\circ}\mathrm{C}$ 1) Only capacitive charge, guaranteed by design.

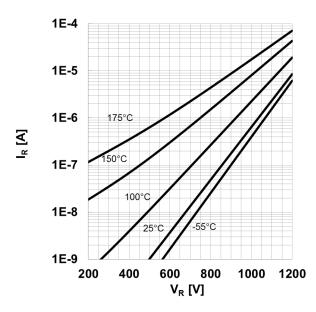


Figure 6. Typical reverse current as function of reverse voltage, $I_R = f(V_R)$, parameter: T_j

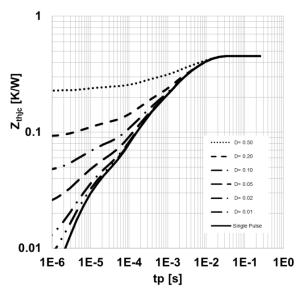


Figure 7. **Max. transient thermal impedance,** $Z_{\text{th,jc}} = f(t_P)$, parameter: $D = t_P/T$

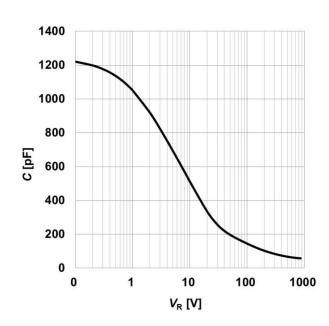


Figure 8. Typical capacitance as function of reverse voltage, $C=f(V_R)$; $T_j=25$ °C; f=1 MHz

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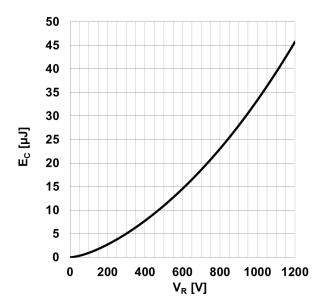
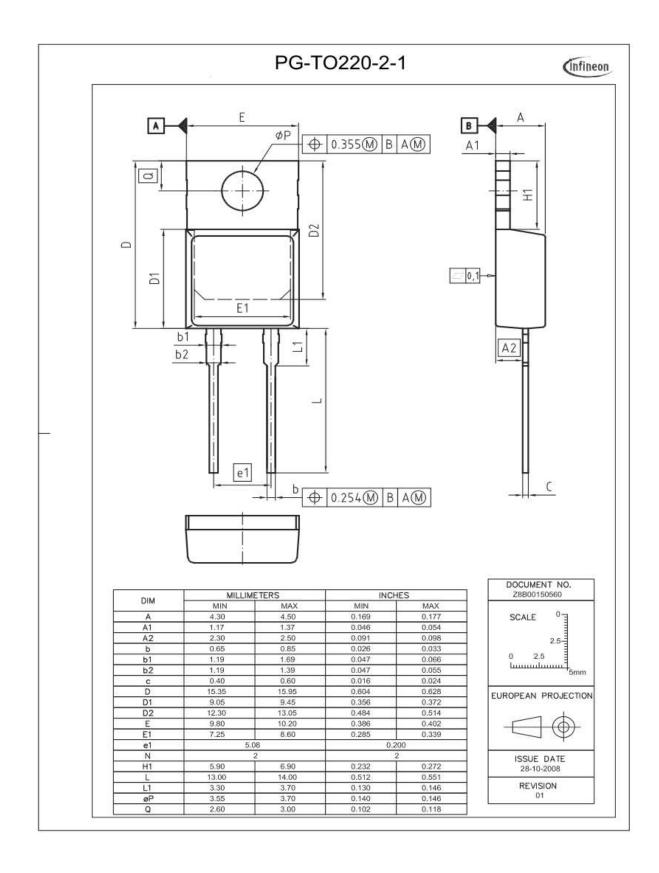


Figure 9. **Typical capacitively stored energy as** function of reverse voltage,

$$E_C = \int_{0}^{V_R} C(V)VdV$$







Revision History

IDH20G120C5

Revision: 2015-09-03, Rev. 2.0

Provious Revision:

Trevious revision.					
Revision	Date	Subjects (major changes since last version)			
2.0	_	Final data sheet			

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